

<b>Notice of References Cited</b>	Application/Control No. 10/632,869	Applicant(s)/Patent Under Reexamination KIM ET AL.
	Examiner Mark Blouin	Art Unit 2653

**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-5,136,565	08-1992	Ooyama et al.	369/44.14
B	US-2003/0193854	10-2003	Lee et al.	369/44.16
C	US-			
D	US-			
E	US-			
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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